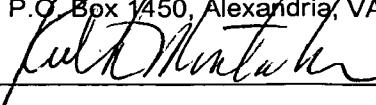


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/ Ruth Montalvo Date: **04/29/05**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Attorney's Docket No.: **GK-ZEI-3269/500343.20289**

U.S. Application No.:

International Application No.: **PCT/EP2004/006302**

International Filing Date: **JUNE 11, 2004** **11 JUNE 2004**

Priority Date Claimed: **JUNE 12, 2003** **12 JUNE 2003**

Title of Invention: **METHOD FOR DETERMINING THE IMAGE QUALITY OF AN OPTICAL IMAGING SYSTEM**

Applicant(s) for (DO/EO/US): **Thomas ENGEL and Herbert GROSS**

Mail Stop PCT  
Commissioner For Patents  
P.O. Box 1450  
Alexandria, VA 22313-450

**INFORMATION DISCLOSURE STATEMENT**

SIR:

Applicant herewith submits together with the simultaneously filed National Phase application of PCT/EP2004/006302, a copy of the International Search Report (PCT/ISA/210) dated October 20, 2004 and German Examination Report (103 27 019.1) dated March 4, 2004, citing some of the following references:

	Document Number	Date	Name and/or Country	English Translation
<b>AA</b>	<b>5,066,119</b>	<b>11/19/1991</b>	<b>Bertand</b>	
<b>AB</b>	<b>2002/0057495</b>	<b>05/16/2002</b>	<b>Kuramoto</b>	
<b>AL</b>	<b>38 42 144</b>	<b>06/21/1990</b>	<b>Germany</b>	Abstract only
<b>AM</b>	<b>95/34800</b>	<b>12/21/1995</b>	<b>WIPO</b>	
<b>AN</b>	<b>10-170399</b>	<b>06/26/1998</b>	<b>Japan</b>	Abstract only
<b>AO</b>	<b>99/66308</b>	<b>12/23/1999</b>	<b>WIPO</b>	
<b>AP</b>	<b>1 079 223</b>	<b>02/28/2001</b>	<b>European</b>	
<b>AQ</b>	<b>1 246 014</b>	<b>10/02/2002</b>	<b>European</b>	
<b>AR</b>	<b>101 54 125</b>	<b>05/22/2003</b>	<b>Germany</b>	Abstract only
OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)				
<b>AX</b>	<b>Literature: Joseph Geary, "Wavefront sensors", SPIE Press 1995</b>			
<b>AY</b>	<b>Literature: Daniel Malacara, "Optical Shop Testing", Wiley Verlag 1992</b>			

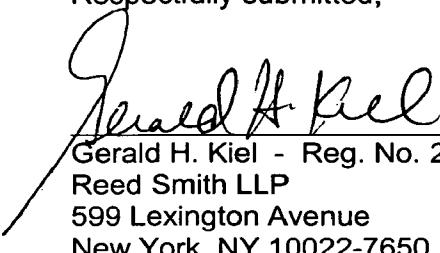
ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /M.S./

Accompanying this Information Disclosure Statement and form PTO-1449 are copies of the 7 foreign documents including 3 English Abstracts, first pages of the 2 U.S. documents except articles AX and AY. Articles AX-AY are mentioned on page 3 of the substitute specification.

The USPTO waived the requirement under 37 C.F.R. §1.98(a)(2)(i) for submitting copies of US patents and US patent application publications in all U.S. applications filed after June 30, 2003.

This submission is not an admission that the information disclosed in the documents is material to the patentability of the invention disclosed and/or claimed in the above-identified application.

Respectfully submitted,



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04/29/05  
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Enclosures:

Search Reports (PCT/ISA/210);  
German Examination Report  
PTO-1449;  
2 U.S. first pages  
7 documents  
3 English Abstracts

## LIST OF PRIOR ART CITED BY APPLICANT

(Filed on April 29, 2005)

JC20 Rec'd PCT/PTO 29 APR 2016

Docket No. **GK-ZEI-3269/500343.20289**

Applicant(s): **Thomas ENGEL and Herbert GROSS**

Application No. (Int'l Appln No. PCT/EP2004/006302 11JUNE04) Group:

Filed: Concurrently herewith – April 29, 2005

**Examiner:**

## U.S. PATENT DOCUMENTS

Exam. Init		Document Number	Date	Name	Class	Sub-Class	Filing Date Appropriate
	<b>AA</b>	<b>5,066,119</b>	<b>11/19/1991</b>	<b>Bertand</b>			
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	<b>AH</b>						
	<b>AI</b>						
	<b>AJ</b>						
	<b>AK</b>						

## FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	CLASS	Sub-Class	Translation	
							YES	NO
	<b>AL</b>	<b>38 42 144</b>	<b>06/21/1990</b>	<b>Germany</b>			<b>Abstract only</b>	
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	<b>AS</b>							
	<b>AT</b>							

**OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

AX	Literature: Joseph Geary, "Wavefront sensors", SPIE Press 1995
AY	Literature: Daniel Malacara, "Optical Shop Testing", Wiley Verlag 1992
AZ	

**\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.**

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /M.S./